

**Search Notes**

Application/Control No.

10/774,037

Examiner

M. Lee

Applicant(s)/Patent under  
Reexamination

GOYAL ET AL.

Art Unit

2622

**SEARCHED**

Class	Subclass	Date	Examiner
348	725	6/15/2006	ML
725	111, 131		
	151, 110		
	54		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	6/15/2006	ML